DC TO 25GHz GaAs SPST SWITCH

### Package: Die, 1.91mm x 1.11mm x 0.10mm

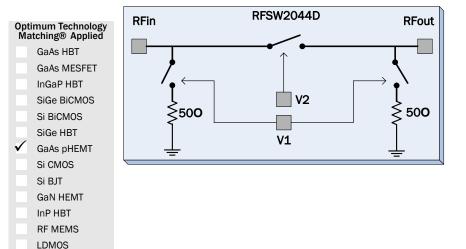


## **Product Description**

RFMD

rfmd.com

RFMD's RFSW2044D is an absorptive SPST GaAs microwave monolithic integrated circuit (MMIC) switch designed using the RFMD FD05  $0.5\mu$ m switch process. It offers absorptive properties from both ports (50 $\Omega$  terminations). The RFSW2044D is developed for broadband communications, instrumentation and electronic warfare.



### **Features**

- Low Insertion Loss: 1.5dB at 20GHz
- High Isolation: 43dB at 20GHz
- Excellent Return Loss
- Absorptive Input and Output
- 20nS Switching Speed
- GaAs pHEMT Technology

## **Applications**

- Broadband Communications
- Test Instrumentation
- Fiber Optics
- Military
- Aerospace

Parameter	Specification			Unit	Condition	
Farameter	Min. Typ.		Max.	Unit	Condition	
Operating Frequency	DC		25	GHz		
Insertion Loss (OGHz to 5GHz)		1.0	1.6	dB	ON State	
Insertion Loss (5GHz to 10GHz)		1.3	1.8	dB	ON State	
Insertion Loss (10GHz to 15GHz)		1.4	2.0	dB	ON State	
Insertion Loss (15GHz to 20GHz)		1.5	2.3	dB	ON State	
Insertion Loss (20GHz to 25GHz)		1.6		dB	ON State	
Isolation (OGHz to 10GHz)	42	50		dB	OFF State	
Isolation (10GHz to 20GHz)	36	43		dB	OFF State	
Isolation (20GHz to 25GHz)		43		dB	OFF State	
Input Return Loss (DC to 25GHz)	13	17		dB	ON State	
Output Return Loss (DC to 25GHz)	13	17		dB	ON State	
IIP3	43	46		dBm	100MHz spacing 2dBm input	
IIP2	73	81		dBm	100MHz spacing 2dBm input	
Switching Speed		20	28	ns	50% control to 90% RF	
Control Current		16	25	uA	Sum of all control lines	
Control Voltage	-3	-5	-8	V <sub>DC</sub>		

Electrical Specifications,  $T_A = +25$  °C,  $V_{CTRL} = -5V_{DC}$ 

support, contact RF

(+1) 326-678-5570 or sales-supporter

find c

7628 Thorndike Road, Greensboro, NC 27409-9421 · For sales or technical



#### rfmd.com

### **Absolute Maximum Ratings**

Parameter	Rating	Unit
Drain Bias Voltage (V <sub>CTRL</sub> )	-10	V <sub>DC</sub>
RF Port Power	+21	dBm
Storage Temperature	-40 to +150	°C
Operating Temperature	-40 to +85	°C
ESD JESD22-A114 Human Body Model (HBM)	Class 1A (All Pads)	



### **Caution!** ESD sensitive device.

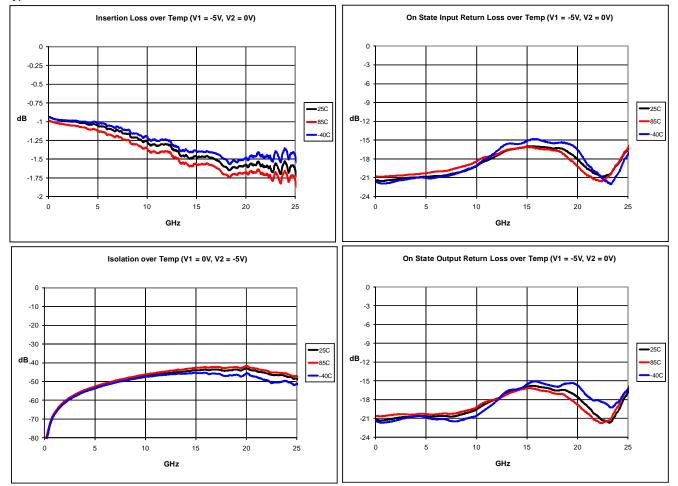
Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability. Specified typical performance or functional operation of the device under Absolute Maximum Rating conditions is not implied.

The information in this publication is believed to be accurate and reliable. However, no responsibility is assumed by RF Micro Devices, Inc. ("RFMD") for its use, nor for any infringement of patents, or other rights of third parties, resulting from its use. No license is granted by implication or otherwise under any patent or patent rights of RFMD. RFMD reserves the right to change component circuitry, recommended application circuitry and specifications at any time without prior notice.

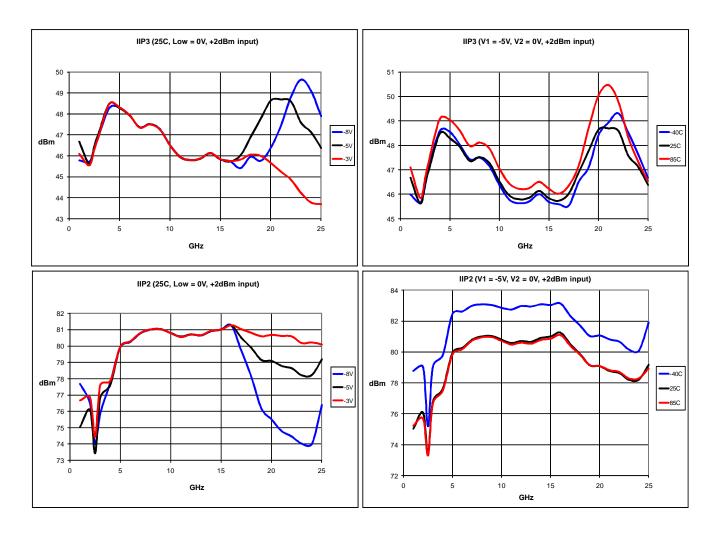


RFMD Green: RoHS compliant per EU Directive 2002/95/EC, halogen free per IEC 61249-2-21, < 1000 ppm each of antimony trioxide in polymeric materials and red phosphorus as a flame retardant, and <2% antimony in solder.

#### **Typical Electrical Performance**

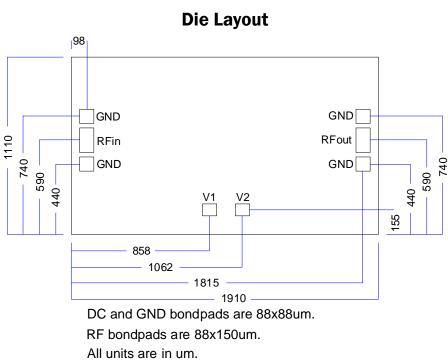
















rfmd.com



Pad	Description	Interface Schematic
RFIN	RF input. This pad is DC coupled and matched to $50\Omega$ from DC to 20GHz. $50\Omega$ microstrip transmission line on 0.127mm (5mil) thick alumina thin film substrate is recommended.	RFin 500hm
RFOUT	RF output. This pad is DC coupled and matched to $50\Omega$ from DC to $20$ GHz. $50\Omega$ microstrip transmission line on 0.127mm (5mil) thick alumina thin film substrate is recommended.	S RFout
V1, V2	DC control for switch operation. Nominal operating voltage is -5V.	S 2kohm S 2kohm S 5.8pF Vctrl
GND	Provides ground patch for probe measurements.	

#### **Truth Table**

Control	RF Path	
V1	V2	RFIN - RFOUT
High	Low	ON (low loss)
Low	High	OFF (high isolation)

High = -3V to -8V (-5V nominal), Low = 0,  $\pm 0.2V$ 





### Measurement Technique

All specifications and typical performances reported in this document were based on data taken with the equipment listed in the stated manner.

Data was taken using a temperature controlled probe station utilizing 150um pitch GSG probes. The probes were placed on a ceramic coplanar to microstrip launch. The launch was then wire bonded to the die using two 1 mil bondwires. The spacing between the launch and the die was 200um, and the bondwire loop height was 100um. the thickness of the test interface was 125um (5mil).

The calibration included the probes and test interfaces, so that the measurement reference plane was at the point of bondwire attachment. Therefore, all data represents the part and accompanying bondwires.

Insertion Loss, Return Loss, and Isolation data were taken using an Agilent E8363B PNA.

IIP3 and IIP2 data were taken utilizing a pair of Agilent E8257D signal generators and an Agilent E4446A PSA.

#### **Preferred Assembly Instructions**

GaAs devices are fragile and should be handled with great care. Specially designed collets should be used where possible. The back of the die is metallized and the recommended mounting method is by the use of conductive epoxy. Epoxy should be applied to the attachment surface uniformly and sparingly to avoid encroachment of epoxy onto the top face of the die. Ideally it should not exceed half the chip height. For automated dispense Ablestick LMISR4 is recommended and for manual dispense Ablestick 84-1 LMI or 84-1 LMIT are recommended. These should be cured at a temperature of  $150^{\circ}$ C for one hour in an oven especially set aside for epoxy curing only. If possible the curing oven should be flushed with dry nitrogen. The gold-tin (80% Au 20% Sn) eutectic die attach has a melting point of approximately 280°C but the absolute temperature being used depends on the leadframe material used and the particular application. The time at maximum temperature should be kept to a minimum. This part has gold (Au) bond pads requiring the use of gold (99.99% pure) bondwire. It is recommended that 25.4um diameter gold wire be used. Recommended lead bond technique is thermocompression wedge bonding with 0.001" (25µm) diameter wire. Bond force, time stage temperature, and ultrasonics are all critical parameters and the settings are dependent on the setup and application being used. Ultrasonic or thermosonic bonding is not recommended. Bonds should be made from the die first and then to the mounting substrate or package. The physical length of the bondwires should be minimized especially when making RF or ground connections.

### Handling Precautions

To avoid damage to the devices, care should be exercised during handling. Proper Electrostatic Discharge (ESD) precautions should be observed at all stages of storage, handling, assembly, and testing.

### ESD/MSL Rating

These devices should be treated as Class 1A (250V to 500V) using the human body model as defined in JEDEC Standard No. 22-A114. Further information on ESD control measures can be found in MIL-STD-1686 and MIL-HDBK-263. This is an unpackaged part and therefore no MSL rating applies.

Part Number	Description	Delivery Method	Quantity		
RFSW2044DS2	Sample, DC to 25GHz GaAs SPST Switch	Waffle pack	2 pc		
RFSW2044DSB	Sample, DC to 25GHz GaAs SPST Switch	Waffle pack	5 pc		
RFSW2044DSQ	Small Quantity, DC to 25GHz GaAs SPST Switch	Waffle pack	25 pc		
RFSW2044D	DC to 25GHz GaAs SPST Switch	Waffle pack	100 pc		

### **Ordering Information**